

MOS FIELD EFFECT TRANSISTOR

2SK3510

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3510 is N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

• Super low on-state resistance:

 $R_{DS(on)} = 8.5 \, m\Omega \, MAX. \, (V_{GS} = 10 \, V, \, I_{D} = 42 \, A)$

- Low Ciss: Ciss = 8500 pF TYP.
- Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3510	TO-220AB		
2SK3510-S	₩ TO-262		
2SK3510-ZJ	TO-263		
2SK3510-Z	TO-220SMD ^{Note}		

Note TO-220SMD package is produced only in Japan.

(TO-220AB)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vss = 0 V)	VDSS	75	O
Gate to Source Voltage (Vps = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	I _{D(DC)}	±83	Α
Drain Current (pulse) Note1	ID(pulse)	±332	Α
Total Power Dissipation (Tc = 25°C)	P _{T1}	125	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	69	Α
Single Avalanche Energy Note2	Eas	450	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 35 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V



(TO-262)



(TO-263, TO-220SMD)



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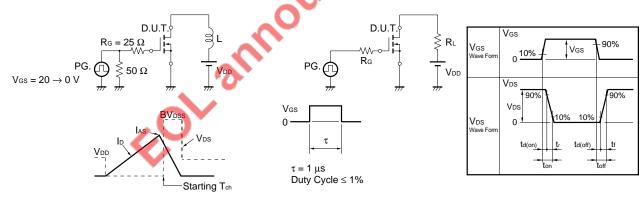


ELECTRICAL CHARACTERISTICS (TA = 25°C)

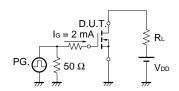
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Inss	Vps = 75 V, Vgs = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 42 A	30	60		S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, ID = 42 A		6.5	8.5	mΩ
Input Capacitance	Ciss	Vps = 10 V		8500		pF
Output Capacitance	Coss	Vgs = 0 V		1300		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		650		pF
Turn-on Delay Time	td(on)	V _{DD} = 38 V, I _D = 42 A		35		ns
Rise Time	tr	V _{GS} = 10 V	4	28		ns
Turn-off Delay Time	t _{d(off)}	$R_G = 0 \Omega$.C	105		ns
Fall Time	tf		5	16		ns
Total Gate Charge	Q _G	V _{DD} = 60 V		150		nC
Gate to Source Charge	Qgs	V _G S = 10 V		30		nC
Gate to Drain Charge	Q _{GD}	ID = 83 A		52		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 83 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 83 A, VGS = 0 V		80		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		240		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

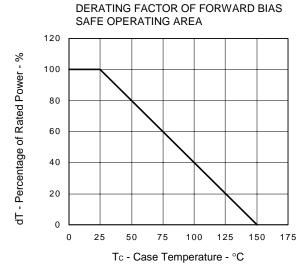
TEST CIRCUIT 2 SWITCHING TIME

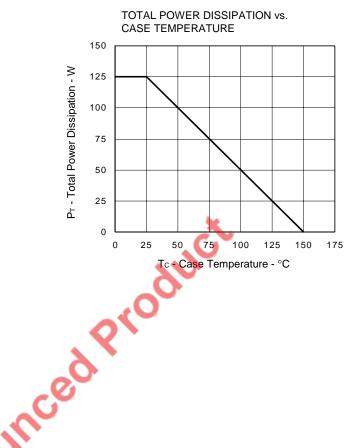


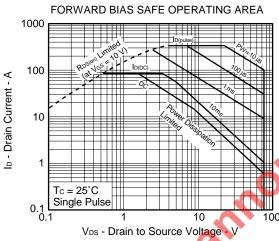
TEST CIRCUIT 3 GATE CHARGE

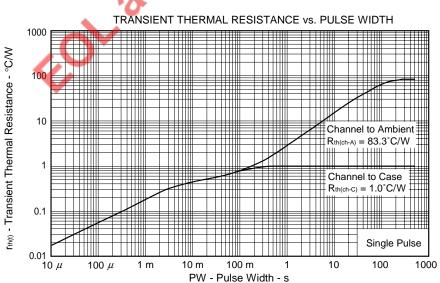


TYPICAL CHARACTERISTICS (TA = 25°C)



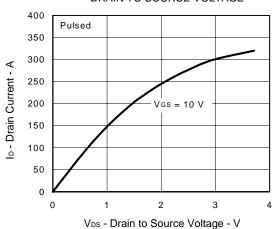




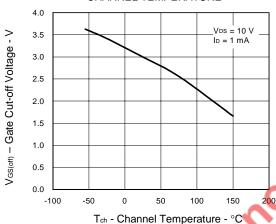


3

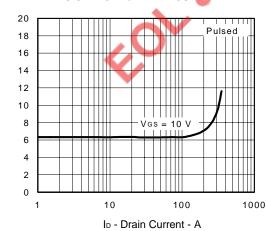
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



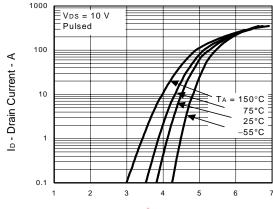
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

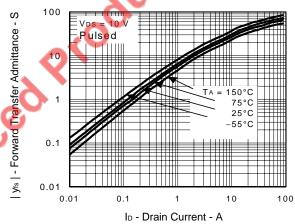


FORWARD TRANSFER CHARACTERISTICS

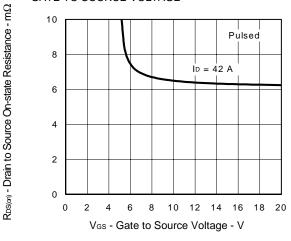


Vgs - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



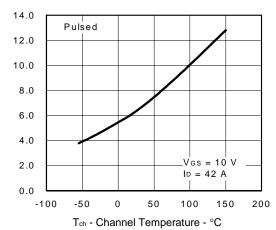
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



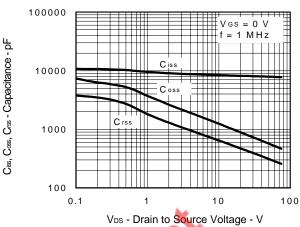
RDS(m) - Drain to Source On-state Resistance - m\Omega

R_{DS(m)} - Drain to Source On-state Resistance - mΩ

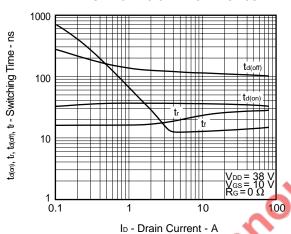
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



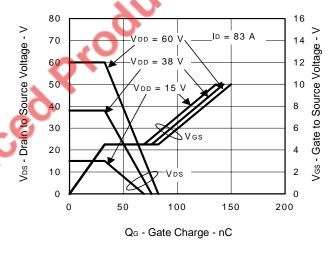
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



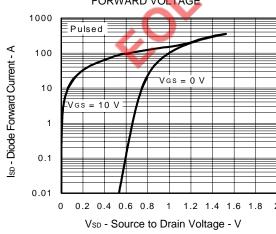
SWITCHING CHARACTERISTICS



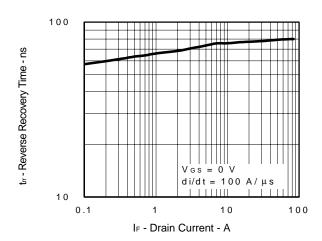
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

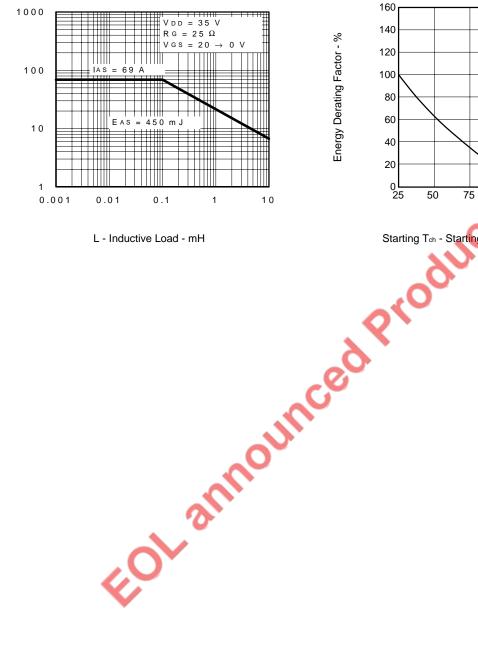


REVERSE RECOVERY TIME vs. DRAIN CURRENT

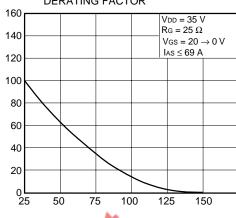


IAS - Single Avalanche Current - A

SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY **DERATING FACTOR**



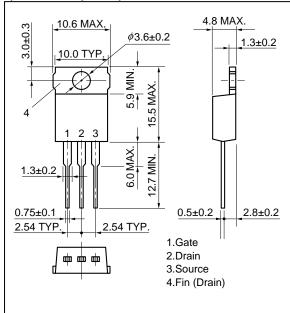
Energy Derating Factor - %

Starting T_{ch} - Starting Channel Temperature - °C

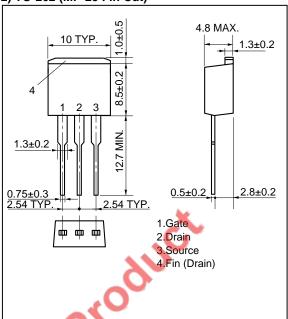


PACKAGE DRAWINGS (Unit: mm)

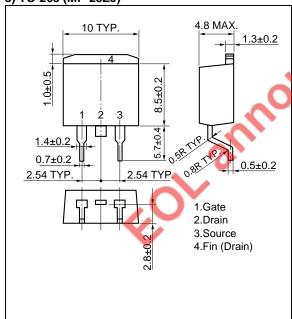
1) TO-220AB (MP-25)



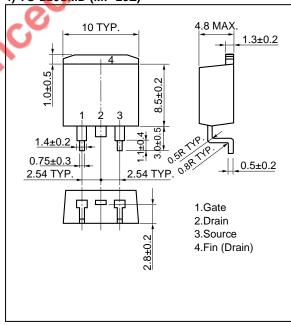
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)

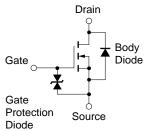


4) TO-220SMD (MP-25Z)^{Note}



Note This package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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